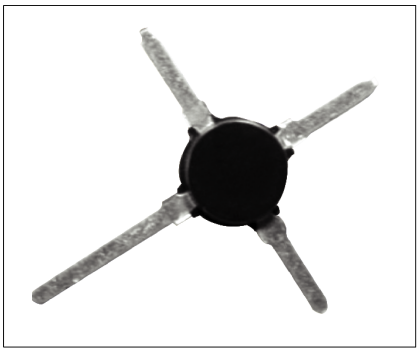
NPN Silicon High-Frequency Transistors

- High Gain–Bandwidth Product
  f_T = 8.0 GHz (Typ) @ 50 mA
- Low Noise Figure
  NF_{min} = 1.6 dB (Typ) @ f = 1.0 GHz

I_C = 80 mA
LOW NOISE
HIGH–FREQUENCY
TRANSISTORS



MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Collector–Emitter Voltage	V_{CEO}	10	Vdc
Collector–Base Voltage	V_{CBO}	20	Vdc
Emitter–Base Voltage	V_{EBO}	3.0	Vdc
Collector Current — Continuous	I_C	80	mA
Total Device Dissipation (1) @ T_C = 75°C Derate above 75°C MRF571	P_D	0.58 7.73	Watts mW/°C
Operating and Storage Temperature	T_{stg}	–55 to +150	°C

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ELECTRICAL CHARACTERISTICS (T_A = 25°C unless otherwise noted)

Characteristic			Symbol	Min	Typ	Max	Unit
OFF CHARACTERISTICS							
Collector–Emitter Breakdown Voltage (I_C = 1.0 mA, I_B = 0)			$V_{(BR)CEO}$	10	12	—	Vdc
Collector–Base Breakdown Voltage (I_C = 0.1 mA, I_E = 0)			$V_{(BR)CBO}$	20	—	—	Vdc
Emitter–Base Breakdown Voltage (I_E = 50 μAdc, I_C = 0)			$V_{(BR)EBO}$	2.5	—	—	Vdc
Collector Cutoff Current (V_{CB} = 8.0 Vdc, I_E = 0)			I_{CBO}	—	—	10	μAdc
ON CHARACTERISTICS							
DC Current Gain (I_C = 30 mAdc, V_{CE} = 5.0 Vdc)			h_{FE}	50	—	300	—
DYNAMIC CHARACTERISTICS							
Collector–Base Capacitance (V_{CB} = 6.0 Vdc, I_E = 0, f = 1.0 MHz)	MRF571		C_{cb}	—	0.75	1.0	pF
Current Gain–Bandwidth Produc (V_{CE} = 8.0 Vdc, I_C = 50 mAdc, f = 1.0 GHz)	MRF571		f_T	—	8.0	—	GHz
FUNCTIONAL TESTS							
Gain @ Noise Figure	MRF571	f = 0.5 GHz	G_{NF}	—	16.5	—	dB
(I_C = 10 mAdc, V_{CE} = 6.0 Vdc)	MRF571	f = 1.0 GHz		10	12	—	
Noise Figure	MRF571	f = 0.5 GHz	NF	—	1.0	—	dB
(I_C = 10 mAdc, V_{CE} = 6.0 Vdc)	MRF571	f = 1.0 GHz		—	1.5	2.0	
		f = 2.0 GHz		—	2.8	—	

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TYPICAL CHARACTERISTICS
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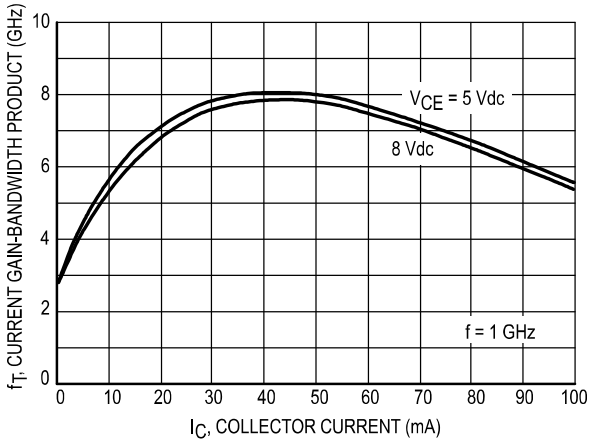
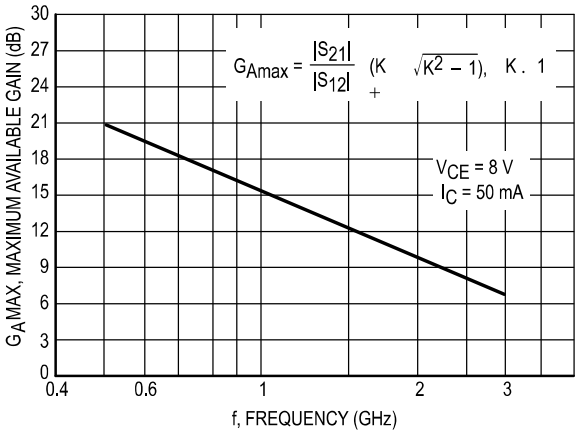
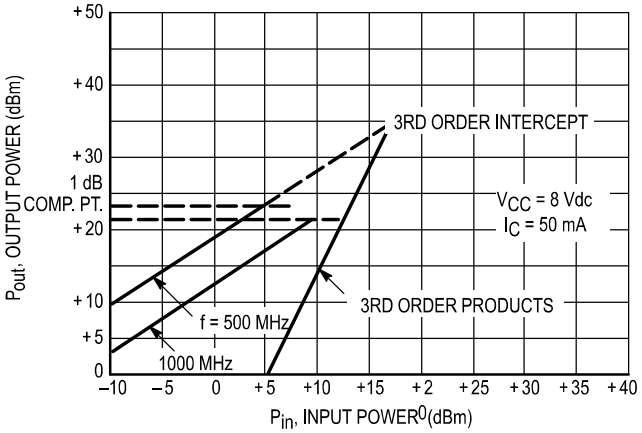


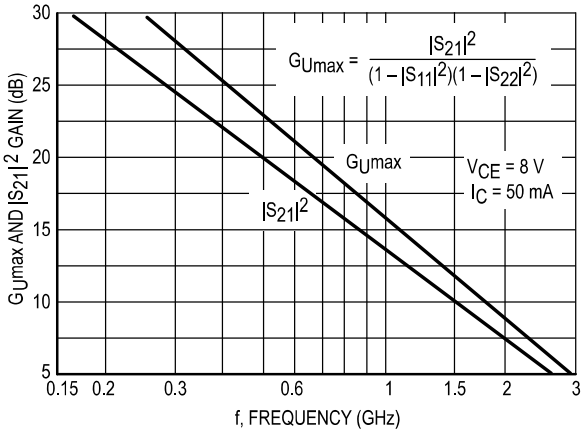
f_T, Current Gain–Bandwidth Product versus Collector Current



G_{Amax}, Maximum Available Gain versus Frequency



1.0 dB Compression Point and Third Order Intercept



G_{Umax} and $|S_{21}|^2$ versus Frequency

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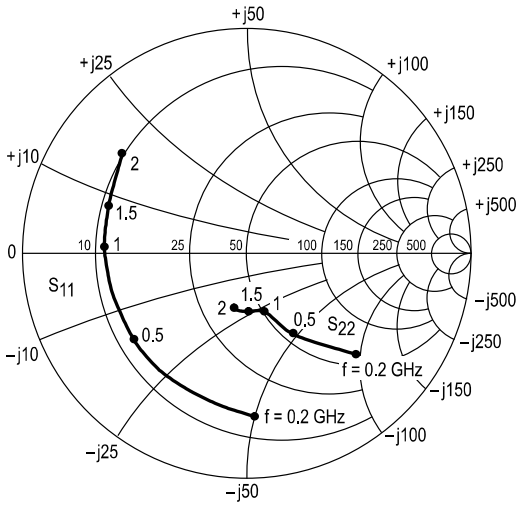
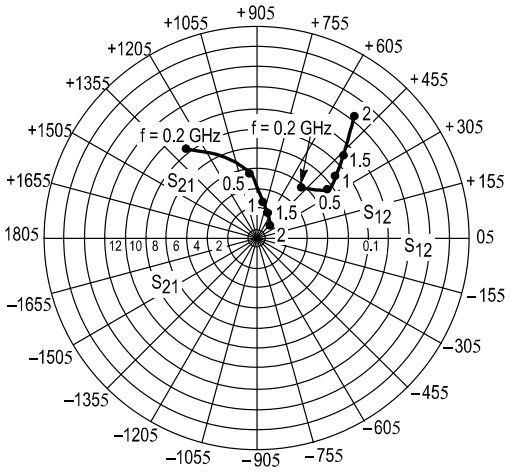


Input/Output Reflection Coefficients versus Frequency (GHz)
V_{CE} = 6.0 V, I_C = 5.0 mA



Forward/Reverse Transmission Coefficients versus Frequency (GHz)
V_{CE} = 6.0 V, I_C = 5.0 mA

V_{CE} (Volts)	I_C (mA)	f (MHz)	S_{11}		S_{21}		S_{12}		S_{22}	
			$\|S_{11}\|$	$-\phi$	$\|S_{21}\|$	$-\phi$	$\|S_{12}\|$	$-\phi$	$\|S_{22}\|$	$-\phi$
6.0	5	200	0.74	−86	10.5	129	0.06	48	0.69	−42
		500	0.62	−143	5.5	97	0.08	33	0.41	−59
		1000	0.61	178	3.0	78	0.09	37	0.28	−69
		1500	0.65	158	2.0	62	0.11	44	0.26	−88
		2000	0.70	140	1.6	51	0.14	51	0.27	−99
	10	200	0.64	−111	15	118	0.04	44	0.53	−59
		500	0.58	−160	6.9	93	0.06	42	0.27	−77
		1000	0.59	168	3.7	77	0.09	52	0.16	−91
		1500	0.63	151	2.5	64	0.12	56	0.16	−113
		2000	0.67	134	2.0	53	0.16	57	0.16	−118
	50	200	0.56	−160	20.4	102	0.02	57	0.27	−98
		500	0.57	176	8.4	86	0.05	67	0.14	−130
		1000	0.60	156	4.4	75	0.09	70	0.11	−164
		1500	0.62	152	2.9	64	0.13	68	0.13	−175
		2000	0.66	127	2.4	53	0.18	62	0.11	−178
8.0	5	200	0.75	−83	10.7	129	0.06	49	0.71	−39
		500	0.62	−140	5.1	98	0.08	34	0.43	−54
		1000	0.60	−179	3.7	78	0.09	38	0.31	−62
		1500	0.64	159	2.1	62	0.10	45	0.29	−80
		2000	0.69	141	1.7	52	0.13	52	0.29	−91
	10	200	0.64	−99	15.1	120	0.05	46	0.54	−60
		500	0.52	−152	7.1	94	0.07	45	0.32	−75
		1000	0.52	170	3.7	76	0.10	54	0.15	−82
		1500	0.52	150	2.5	62	0.13	56	0.16	−108
		2000	0.57	133	2.0	51	0.18	55	0.16	−107
	50	200	0.52	−153	19.6	102	0.03	56	0.28	−92
		500	0.52	178	8.1	86	0.05	67	0.16	−98
		1000	0.56	157	4.1	73	0.10	70	0.06	−130
		1500	0.54	139	2.8	62	0.13	68	0.11	−146
		2000	0.59	126	2.2	52	0.19	63	0.10	−137

MRF571 Common Emitter S–Parameters

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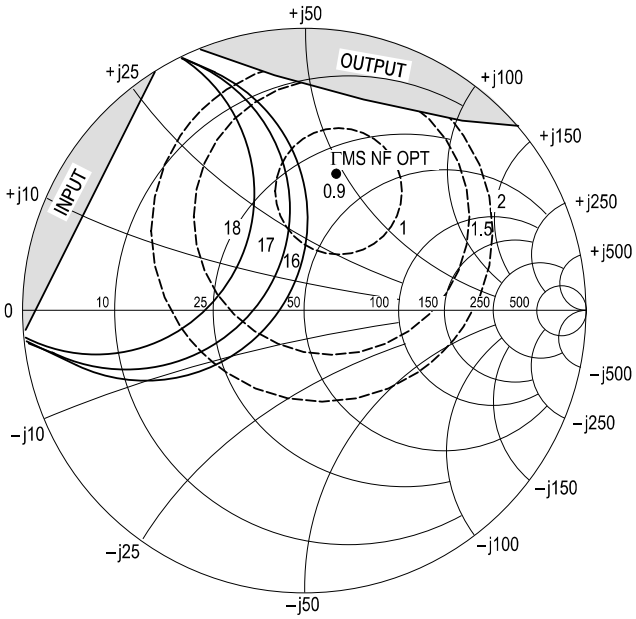
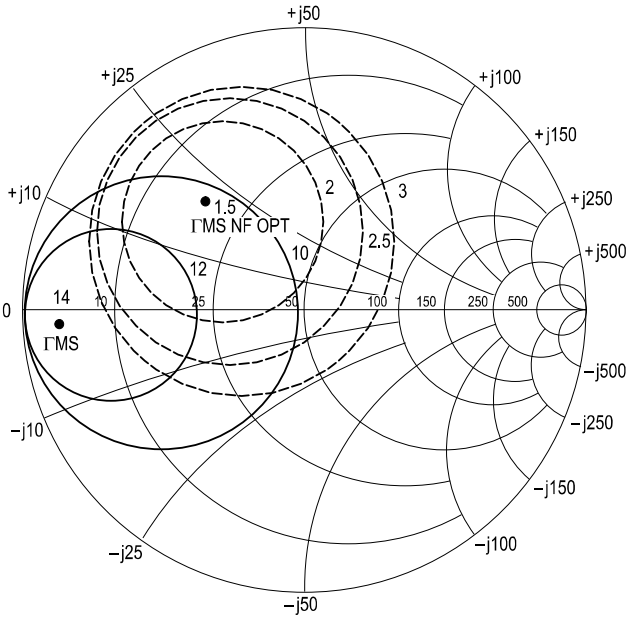


V_{CE} = 6.0 V, I_C = 5.0 mA
f = 500 MHz
▢ — REGION OF INSTABILITY

f (GHz)	NF OPT (dB)	Rn (Ω)	NF50 Ω (dB)
0.5	0.9	9.3	1.3

ΓMS NF OPT	K
0.49 – 745	0.58



V_{CE} = 6.0 V, I_C = 5.0 mA
f = 1.0 GHz

f (GHz)	NF OPT (dB)	Rn (Ω)	NF50 Ω (dB)	ΓMS NF OPT
1.0	1.5	7.5	2.2	0.48 – 1345

ΓMS	ΓML
0.89 – −1795	0.81 – 665

MRF571 Constant Gain and Noise Figure Contours

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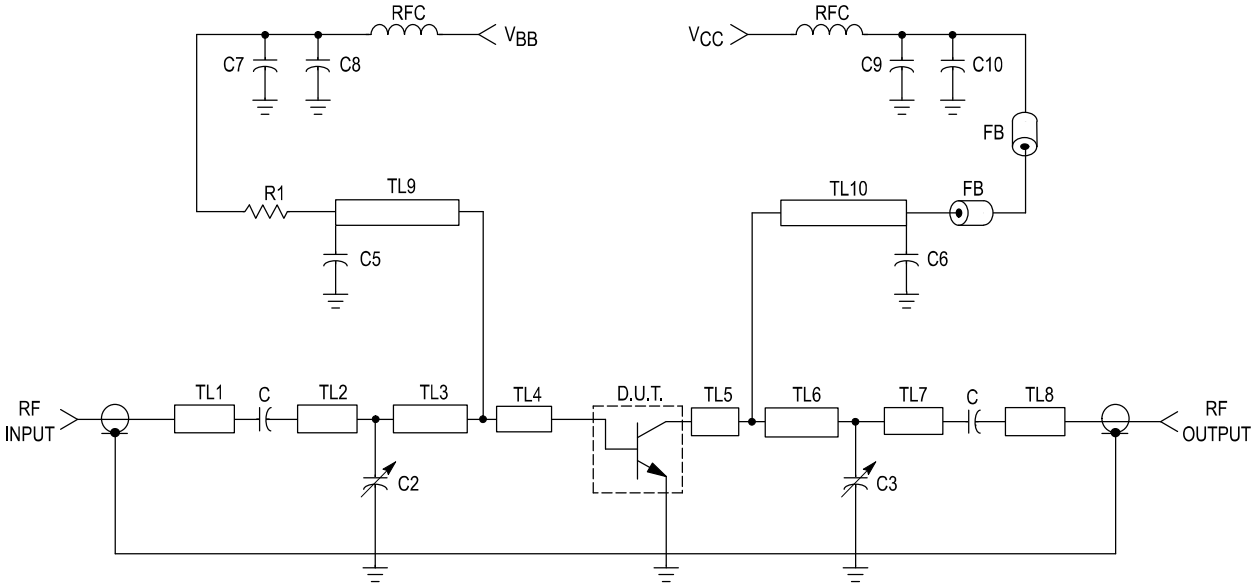

C1, C4, C5, C6, C8, C9 — 100 pF Chip Capacitor
C2, C3 — 0.8–8.0 pF Johanson Capacitor
C7, C10 — 10 μF Tantalum Capacitor
R1 — 1.0 kOhms Res.
RFC — VK–200, Ferroxcube
FB — Ferrite Bead, Ferroxcube 56–590–65/3B
Board Material — 0.0625, Glass Teflon, ε_r = 2.55

TL1, TL7, TL8 — Microstrip 0.162, x 0.600,
TL2 — Microstrip 0.162, x 1.060,
TL3 — Microstrip 0.162, x 0.700,
TL4, TL5 — Microstrip 0.162, x 0.440,
TL6 — Microstrip 0.162, x 1.140,
TL8, TL9 — Microstrip 0.020, x 2.130,

MRF571 Test Circuit Schematic

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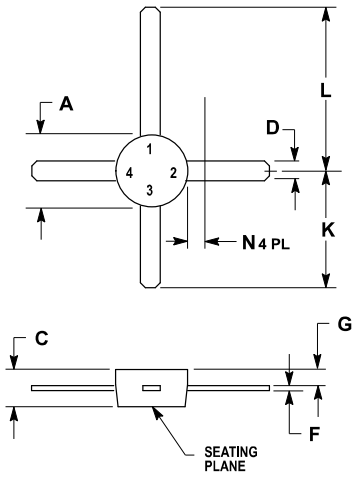
PACKAGE DIMENSIONS



NOTES:
1. DIMENSION D NOT APPLICABLE IN ZONE N.

	MILLIMETERS		INCHES	
DIM	MIN	MAX	MIN	MAX
A	4.44	5.21	0.175	0.205
C	1.90	2.54	0.075	0.100
D	0.84	0.99	0.033	0.039
F	0.20	0.30	0.080	0.012
G	0.76	1.14	0.030	0.045
K	7.24	8.13	0.285	0.320
L	10.54	11.43	0.415	0.450
N	—	1.65	—	0.065

STYLE 2:
PIN 1. COLLECTOR
2. EMITTER
3. BASE
4. EMITTER

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